Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/777,069	OOISHI, TSUKASA	
Examiner	Art Unit	
Lv D. Pham	2827	

	SEAR	CHED	
Class	Subclass	Date	Examiner
365	158, 171, 172, 173	8/24/2005	LP
365		8/25/2005	LP
365	230.03	8/25/2005	LP
365	230.06	8/25/2005	LP
365	230.07	8/25/2005	LP
365	231	8/25/2005	LP
365	231	8/25/2005	LP
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East (all databases)	8/24/2005	LP	